

Special Issue

Single Photon Technologies

Message from the Guest Editors

Papers are solicited in the following areas:

- Single-photon detectors: devices, circuits, and systems to achieve single-photon sensitivity;
- Single-photon sources: materials, schemes, and architectures to generate and control light emission at single photon level;
- Applications: single-photon technologies for scientific and industrial applications, from ground to space and from life science to quantum information processing;
- Metrology/validation techniques and instrumentation to prove single-photon generation and acquisition.

Guest Editors

Dr. Ivan Rech

Dipartimento di Elettronica, Informazione e Bioingegneria, Politecnico Milano, Via Ponzio 34/5, 20133 Milano, Italia

Dr. Giulia Acconcia

Department of Electronics, Information and Bioengineering, Politecnico di Milano, 20132 Milan, Italy

Deadline for manuscript submissions

closed (30 May 2020)



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Applied Sciences
Editorial Office
MDPI, Grosspeteranlage 5
4052 Basel, Switzerland
Tel: +41 61 683 77 34
appls@mdpi.com

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About the Journal

Message from the Editor-in-Chief

As the world of science becomes ever more specialized, researchers may lose themselves in the deep forest of the ever increasing number of subfields being created. This open access journal Applied Sciences has been started to link these subfields, so researchers can cut through the forest and see the surrounding, or quite distant fields and subfields to help develop his/her own research even further with the aid of this multi-dimensional network.

Editor-in-Chief

Prof. Dr. Giulio Nicola Cerullo
Dipartimento di Fisica, Politecnico di Milano, Piazza L. da Vinci 32,
20133 Milano, Italy

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